



Dual N-Channel 30 V (D-S) MOSFET



PRODU	CT SUMMARY		
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A)	Q _g (TYP.)
	0.0192 at V _{GS} = 10 V	6 ^a	
30	0.0220 at V _{GS} = 6 V	6 ^a	4.7 nC
	0.0245 at V _{GS} = 4.5 V	6 ^a	

Marking Code: CG
Ordering Information:

Si5922DU-T1-GE3 (lead (Pb)-free and halogen-free)

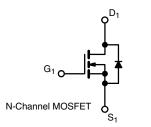
FEATURES

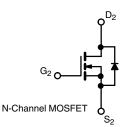
- TrenchFET® power MOSFET
- 100 % R_q and UIS tested
- New thermally enhanced PowerPAK® ChipFET® package
 - Small footprint area
 - Low on-resistance
 - Thin 0.8 mm profile
- Material categorization: for definitions of compliance please see <u>www.vishav.com/doc?99912</u>



APPLICATIONS

• DC/DC power supply





ABSOLUTE MAXIMUM RATINGS	$\Gamma_A = 25 ^{\circ}\text{C}$, unless	s otherwise noted	d)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	30	V
Gate-Source Voltage		V_{GS}	+20 / -16	V
	T _C = 25 °C		6 a	
Continuous Drain Current /T 150 °C)	T _C = 70 °C	1 , 🗀	6 ^a	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	6 ^{a, b, c}	
	T _A = 70 °C		6 a, b, c	
Pulsed Drain Current (t = 100 µs)		I _{DM}	24	A
Continuous Source-Drain Diode Current	T _C = 25 °C	,	6 ^a	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.9 ^{b, c}	
Single Pulse Avalanche Current	1 - 0.1 mH	I _{AS}	10	
Avalanche Energy L = 0.1 mH		E _{AS}	5	mJ
	T _C = 25 °C		10.4	
Mayimum Dawar Dissination	T _C = 70 °C		6.7	W
Maximum Power Dissipation	T _A = 25 °C	P _D	2.3 b, c	VV
	T _A = 70 °C		1.5 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C
Soldering Recommendations (Peak Temperature) d, e			260	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient b, f	t ≤ 5 s	R_{thJA}	43	55	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	Steady State R _{thJC} 9.5 12		C/ VV		

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile (www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 105 °C/W.

Vishay Siliconix

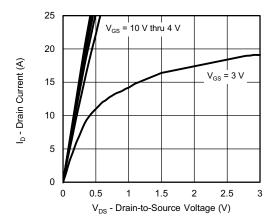
SPECIFICATIONS ($T_J = 25 ^{\circ}\text{C}$, UPARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static	STIVIBUL	TEST CONDITIONS	WIIN.	ITP.	IVIAA.	UNIT	
Drain-Source Breakdown Voltage	V _{DS}	Voc = 0 V In = 250 HA	30	_	_	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	V _{GS} = 0 V, I _D = 250 μA	-	14.3	-		
		I _D = 250 μA		-4.7	_	mV/°C V	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	V V I 050 ·· A		-4.7	- 0.0		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.2	-	2.2		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V} / -16 \text{ V}$	-	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	=	-	10	μA	
On Otata Dunius Oriumanat 8		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	5	- 0.0455	- 0.0400	Α	
		$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	0.0155	0.0192	-	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 6 \text{ V}, I_D = 4 \text{ A}$	-	0.0170	0.0220	Ω	
		$V_{GS} = 4.5 \text{ V}, I_D = 4 \text{ A}$	1	0.0190	0.0245		
Forward Transconductance a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 5 \text{ A}$	-	22	-	S	
Dynamic ^b					T		
Input Capacitance	C _{iss}		-	765	-	pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	ı	225	-		
Reverse Transfer Capacitance	C _{rss}		-	14	-		
C _{rss} /C _{iss} Ratio			-	0.018	0.036	-	
Total Gate Charge	Q _g —	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	10	15	nC	
Total date onlarge		V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 5 A	-	4.7	7.1		
Gate-Source Charge			ı	2.2	-		
Gate-Drain Charge	Q_gd		1	0.65	-		
Output Charge	Q _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}$	-	6.5	-		
Gate Resistance	R_g	f = 1 MHz	1.3	6.3	12.6	Ω	
Turn-On Delay Time	t _{d(on)}		-	6	15		
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω $I_D \cong$ 5 A, V_{GEN} = 10 V, R_g = 1 Ω	-	25	50		
Turn-Off Delay Time	t _{d(off)}		-	15	30		
Fall Time	t _f		-	10	20		
Turn-On Delay Time	t _{d(on)}		1	17	35	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V, R}_{L} = 3 \Omega$	-	45	90	- - -	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5$ A, $V_{GEN} = 4.5$ V, $R_g = 1$ Ω	-	16	30		
Fall Time	t _f		-	27	50		
Drain-Source Body Diode Characteristic	•						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C		-	6		
Pulse Diode Forward Current (t = 100 μs)	I _{SM}	<u> </u>	-	-	24	Α	
Body Diode Voltage	V _{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.81	1.2	V	
Body Diode Reverse Recovery Time			-	21	40	ns	
Body Diode Reverse Recovery Charge	ndy Diode Reverse Recovery Charge		-	10	20	nC	
Reverse Recovery Fall Time	t _a	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	12	-	ns	
Reverse Recovery Rise Time	t _b	1	-	9	_		

Notes

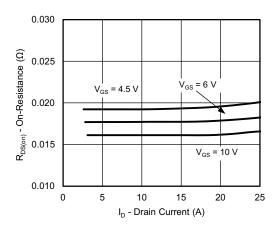
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

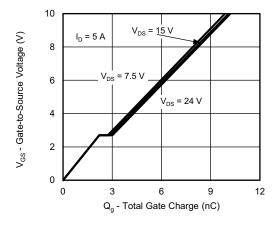




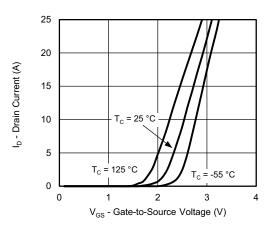
Output Characteristics



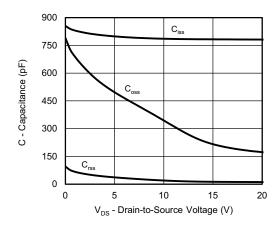
On-Resistance vs. Drain Current and Gate Voltage



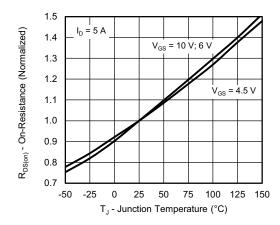
Gate Charge



Transfer Characteristics

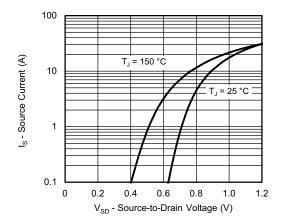


Capacitance

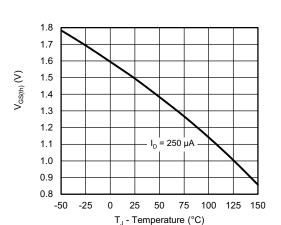


On-Resistance vs. Junction Temperature

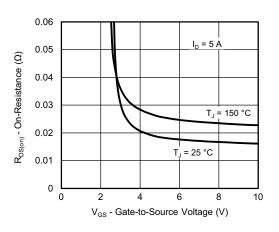




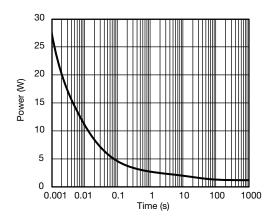
Source-Drain Diode Forward Voltage



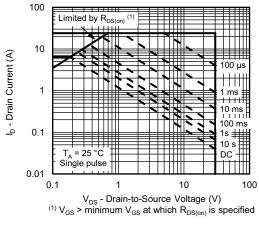
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

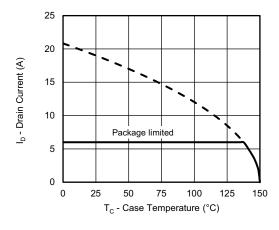


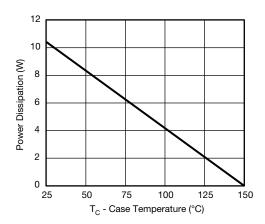
Single Pulse Power, Junction-to-Ambient



Safe Operating Area







Current Derating a

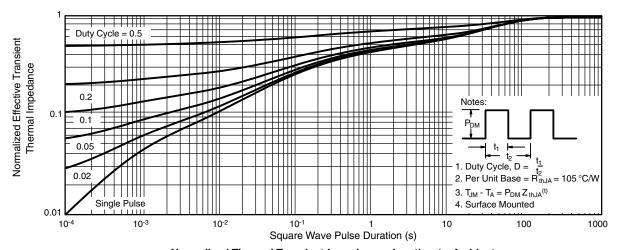
Power Derating

Note

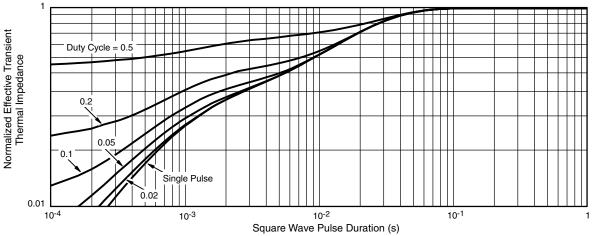
a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

ARE SUBJECT TO SPECIFIC DISCLAIMERS, SET FORTH AT www.vishay.com/doc?91000





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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